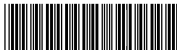


Search Notes**Application/Control No.**

10/553,724

Examiner

KEVIN R. KRUEER

**Applicant(s)/Patent under
Reexamination**

FUJI ET AL

Art Unit

1794

SEARCHED

Class	Subclass	Date	Examiner
428	516,347	3/30/2008	KK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search	3/30/2008	KK
EAST search	3/30/2008	KK